

Notice of References Cited	Application/Control No. 10/003,499	Applicant(s)/Patent Under Reexamination HORWATH ET AL.	
	Examiner Kiet Doan	Art Unit 2683	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,112,089 A	08-2000	Satarasinghe, Prasanna Jayaraj	455/437
	B	US-6,370,377 B1	04-2002	Take et al.	455/432.1
	C	US-6,725,052 B1	04-2004	Raith, Alex Krister	455/518
	D	US-6,430,414 B1	08-2002	Sorokine et al.	455/442
	E	US-6,801,512 B1	10-2004	Cudak et al.	370/332
	F	US-6,360,098 B1	03-2002	Ganesh et al.	455/436
	G	US-6,456,606 B1	09-2002	Terasawa, Daisuke	370/331
	H	US-6,526,283 B1	02-2003	Jang, Jae-Shin	455/456.5
	I	US-2002/0090965 A1	07-2002	Chen et al.	455/522
	J	US-2002/0006805	01-2002	New et al.	455/525
	K	US-6,154,455 A	11-2000	Mekkoth et al.	370/342
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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